On the Shockley-Read-Hall Model: Generation-Recombination in Semiconductors

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January 17, 2006

Abstract

The Shockley-Read-Hall model for generation-recombination of electron-hole pairs in semiconductors based on a quasistationary approximation for electrons in a trapped state is generalized to distributed trapped states in the forbidden band and to kinetic transport models for electrons and holes. The quasistationary limit is rigorously justified both for the drift-diffusion and for the kinetic model.

Keywords: semiconductor, generation, recombination, drift-diffusion, kinetic model

AMS subject classification:

Acknowledgment: This work has been supported by the European IHP network "HYKE-Hyperbolic and Kinetic Equations: Asymptotics, Numerics, Analysis", contract no. HPRN-CT-2002-00282, and by the Austrian Science Fund, project no. W008 (Wissenschaftskolleg "Differential Equations"). Part of it has been carried out while the second and third authors enjoyed the hospitality of the Université des Sciences et Technologies Lille 1.

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1 Introduction

The Shockley-Read-Hall (SRH-)model was introduced in 1952 [13], [9] to describe the statistics of recombination and generation of holes and electrons in semiconductors occurring through the mechanism of trapping.

The transfer of electrons from the valence band to the conduction band is referred to as the generation of electron-hole pairs (or pair-generation process), since not only a free electron is created in the conduction band, but also a hole in the valence band which can contribute to the charge current. The inverse process is termed recombination of electronhole pairs. The bandgap between the upper edge of the valence band and the lower edge of the conduction band is very large in semiconductors, which means that a big amount of energy is needed for a direct band-to-band generation event. The presence of trap levels within the forbidden band caused by crystal impurities facilitates this process, since the jump can be split into two parts, each of them 'cheaper' in terms of energy. The basic mechanisms are illustrated in Figure 1: (a) hole emission (an electron jumps from the valence band to the trapped level), (b) hole capture (an electron moves from an occupied trap to the valence band, a hole disappears), (c) electron emission (an electron jumps from trapped level to the conduction band), (d) electron capture (an electron moves from the conduction band to an unoccupied trap).

Figure 1: The four basic processes of electron-hole recombination.

Models for this process involve equations for the densities of electrons in the conduction band, holes in the valence band, and trapped electrons. Basic for the SRH model are the drift-diffusion assumption for the transport of electrons and holes, the assumption of one trap level in the forbidden band, and the assumption that the dynamics of the trapped electrons is quasistationary, which can be motivated by the smallness of the density of trapped states compared to typical carrier densities. This last assumption leads to the elimination of the density of trapped electrons from the system and to a nonlinear effective recombinationgeneration rate, reminiscent of Michaelis-Menten kinetics in chemistry. This model is an important ingredient of simulation models for semiconductor devices (see, e.g., [10], [12]).

In this work, two generalizations of the classical SRH model are considered: Instead of a single trapped state, a distribution of trapped states across the forbidden band is allowed and, in a second step, a semiclassical kinetic model including the fermion nature of the charge carriers is introduced. Although direct band-to-band recombination-generation (see, e.g., [11]) and impact ionization (e.g., [2], [3]) have been modelled on the kinetic level before, this is (to the knowledge of the authors) the first attempt to derive a 'kinetic SRH model'. (We mention also the modelling discussions and numerical simulations in ??.)

For both the drift-diffusion and the kinetic models with self consistent electric fields existence results and rigorous results concerning the quasistationary limit are proven. For the drift-diffusion problem, the essential estimate is derived similarly to [6], where the quasineutral limit has been carried out. For the kinetic model Degond's approach [4] for the existence of solutions of the Vlasov-Poisson problem is extended. Actually, the existence theory already provides the uniform estimates necessary for passing to the quasistationary limit.

In the following section, the drift-diffusion based model is formulated and nondimensionalized, and the SRH-model is formally derived. Section 3 contains the rigorous justification of the passage to the quasistationary limit. Section 4 corresponds to Section 2, dealing with the kinetic model, and in Section 5 existence of global solutions for the kinetic model is proven and the quasistationary limit is justified.

2 The drift-diffusion Shockley-Read-Hall model

We consider a semiconductor crystal with a forbidden band represented by the energy interval (E_v, E_c) with the valence band edge E_v and the conduction band edge E_c . The constant (in space) number density of trap states N_{tr} is obtained by summing up contributions across the forbidden band:

$$
N_{tr} = \int_{E_v}^{E_c} M_{tr}(E) dE.
$$

Here $M_{tr}(E)$ is the energy dependent density of available trapped states. The position density of occupied traps is given by

$$
n_{tr}(f_{tr})(x,t) = \int_{E_v}^{E_c} M_{tr}(E) f_{tr}(x,E,t) \, dE,
$$

where $f_{tr}(x, E, t)$ is the fraction of occupied trapped states at position $x \in \Omega$, energy $E \in$ (E_v, E_c) , and time $t \geq 0$. Note that $0 \leq f_{tr} \leq 1$ should hold from a physical point of view.

The evolution of f_{tr} is coupled to those of the density of electrons in the conduction band, denoted by $n(x,t) \geq 0$, and the density of holes in the valence band, denoted by $p(x,t) \geq 0$. Electrons and holes are oppositely charged. The coupling is expressed through the following quantities

$$
S_n = \frac{1}{\tau_n N_{tr}} \left[n_0 f_{tr} - n(1 - f_{tr}) \right], \qquad S_p = \frac{1}{\tau_p N_{tr}} \left[p_0 (1 - f_{tr}) - p f_{tr} \right], \tag{1}
$$

$$
R_n = \int_{E_v}^{E_c} S_n M_{tr} dE, \qquad R_p = \int_{E_v}^{E_c} S_p M_{tr} dE.
$$
 (2)

Indeed, the governing equations are given by

$$
\partial_t f_{tr} = S_p - S_n = \frac{p_0}{\tau_p N_{tr}} + \frac{n}{\tau_n N_{tr}} - f_{tr} \left(\frac{p_0 + p}{\tau_p N_{tr}} + \frac{n_0 + n}{\tau_n N_{tr}} \right),\tag{3}
$$

$$
\partial_t n = \nabla \cdot J_n + R_n, \quad J_n = \mu_n (U_T \nabla n - n \nabla V), \tag{4}
$$

$$
\partial_t p = -\nabla \cdot J_p + R_p, \quad J_p = -\mu_p (U_T \nabla p + p \nabla V), \tag{5}
$$

$$
\varepsilon_s \Delta V = q(n + n_{tr}(f_{tr}) - p - C). \tag{6}
$$

For the current densities J_n, J_p we use the simplest possible model, the drift diffusion ansatz, with constant mobilities μ_n , μ_p , and with thermal voltage U_T . Moreover, since the trapped states have fixed positions, no flux appears in (3).

By R_n and R_p we denote the recombination-generation rates for n and p, respectively. The rate constants are $\tau_n(E)$, $\tau_p(E)$, $n_0(E)$, $p_0(E)$, where $n_0(E)p_0(E) = n_i^2$ with the energy independent intrinsic density n_i .

Integration of (3) yields

$$
\partial_t n_{tr} = R_p - R_n. \tag{7}
$$

By adding equations (4) , (5) , (7) , we obtain the continuity equation

$$
\partial_t (p - n - n_{tr}) + \nabla \cdot (J_n + J_p) = 0,\tag{8}
$$

with the total charge density $p - n - n_{tr}$ and the total current density $J_n + J_p$.

In the Poisson equation (6), $V(x,t)$ is the electrostatic potential, ε_s the permittivity of the semiconductor material, q the elementary charge, and $C = C(x)$ the given doping profile.

Note that if τ_n, τ_p, n_0, p_0 are independent from E, or if there exists only one trap level E_{tr} with $M_{tr}(E) = N_{tr} \delta(E - E_{tr})$, then $R_n = \frac{1}{\tau_r}$ $\frac{1}{\tau_n}[n_0\frac{n_{tr}}{N_{tr}}$ $\frac{n_{tr}}{N_{tr}} - n(1 - \frac{n_{tr}}{N_{tr}})$ $\frac{n_{tr}}{N_{tr}}$), $R_p = \frac{1}{\tau_p}$ $\frac{1}{\tau_p}[p_0(1-\frac{n_{tr}}{N_{tr}}$ $\frac{n_{tr}}{N_{tr}}$) — $p\frac{n_{tr}}{N_{tr}}$ $\frac{n_{tr}}{N_{tr}}\big],$ and the equations (4), (5) together with (7) are a closed system governing the evolution of n,p , and n_{tr} .

We now introduce a scaling of n, p, and f_{tr} in order to render the equations (4)-(6) dimensionless:

Scaling of parameters:

- i. $M_{tr} \rightarrow \frac{N_{tr}}{E_c E_v} M_{tr}$.
- ii. $\tau_{n,p} \to \bar{\tau} \tau_{n,p}$, where $\bar{\tau}$ is a typical value for τ_n and τ_p .
- iii. $\mu_{n,p} \to \bar{\mu} \mu_{n,p}$, where $\bar{\mu}$ is a typical value for $\mu_{n,p}$.

iv. $(n_0, p_0, n_i, C) \rightarrow \overline{C}(n_0, p_0, n_i, C)$, where \overline{C} is a typical value of C.

Scaling of unknowns:

v. $(n, p) \rightarrow \overline{C}(n, p)$. vi. $n_{tr} \rightarrow N_{tr} n_{tr}$. vii. $V \to U_T V$. viii. $f_{tr} \rightarrow f_{tr}$.

Scaling of independent variables:

$$
ix. \ E \to E_v + (E_c - E_v)E.
$$

- **x.** $x \to \sqrt{\overline{\mu}U_T\overline{\tau}}x$, where the reference length is a typical diffusion length before recombination.
- xi. $t \rightarrow \bar{\tau}t$, where the reference time is a typical carrier life time.

Dimensionless parameters:

- $\text{xii. } \lambda = \sqrt{\frac{\varepsilon_s}{q\bar{C}}\bar{\mu}\bar{\tau}} = \frac{1}{\bar{x}}$ \bar{x} $\sqrt{\varepsilon_s U_T}$ $\frac{sU_T}{qC}$ is the scaled Debye length.
- **xiii.** $\varepsilon = \frac{N_{tr}}{C}$ is the ratio of the density of traps to the typical doping density, and will be assumed to be small: $\varepsilon \ll 1$.

The scaled system reads:

$$
\varepsilon \partial_t f_{tr} = S_p(p, f_{tr}) - S_n(n, f_{tr}), \quad S_p = \frac{1}{\tau_p} [p_0(1 - f_{tr}) - pf_{tr}], \quad S_n = \frac{1}{\tau_n} [n_0 f_{tr} - n(1 - f_{tr})],
$$
\n(9)

$$
\partial_t n = \nabla \cdot J_n + R_n(n, f_{tr}), \quad J_n = \mu_n(\nabla n - n\nabla V), \quad R_n = \int_0^1 S_n M_{tr} dE, \tag{10}
$$

$$
\partial_t p = -\nabla \cdot J_p + R_p(p, f_{tr}), \quad J_p = -\mu_p(\nabla p + p\nabla V), \quad R_p = \int_0^1 S_p M_{tr} dE, \tag{11}
$$

$$
\lambda^2 \Delta V = n + \varepsilon n_{tr} - p - C, \qquad n_{tr}(f_{tr}) = \int_0^1 f_{tr} M_{tr} dE, \qquad (12)
$$

with $n_0(E)p_0(E) = n_i^2$ and $\int_0^1 M_{tr} dE = 1$.

By letting $\varepsilon \to 0$ in (9) formally, we obtain $f_{tr} = \frac{\tau_n p_0 + \tau_p n}{\tau_n (p + p_0) + \tau_p (n)}$ $\frac{\tau_n p_0 + \tau_p n}{\tau_n (p+p_0) + \tau_p (n+n_0)}$, and the reduced system has the following form

$$
\partial_t n = \nabla \cdot J_n + R(n, p),\tag{13}
$$

$$
\partial_t p = -\nabla \cdot J_p + R(n, p),\tag{14}
$$

$$
R(n,p) = (n_i^2 - np) \int_0^1 \frac{M_{tr}(E)}{\tau_n(E)(p + p_0(E)) + \tau_p(E)(n + n_0(E))} dE,
$$
\n(15)

$$
\lambda^2 \Delta V = n - p - C. \tag{16}
$$

Note that if τ_n, τ_p, n_0, p_0 are independent from E or if there exists only one trap level, then we would have the standard Shockley-Read-Hall model, with $R = \frac{n_i^2 - np}{\tau_n(p+p_0) + \tau_p(n+n_0)}$. Existence and uniqueness of solutions of the limiting system (13) – (16) under the assumptions (21) – (25) stated below is a standard result in semiconductor modelling. A proof can be found in, e.g., $|10|$.

3 Rigorous derivation of the drift-diffusion Shockley-Read-Hall model

We consider the system (9)–(12) with the position x varying in a bounded domain $\Omega \in \mathbb{R}^3$ (all our results are easily extended to the one- and two-dimensional situations), the energy $E \in (0, 1)$, and time $t > 0$, subject to initial conditions

$$
n(x,0) = n_I(x), \quad p(x,0) = p_I(x), \quad f_{tr}(x,E,0) = f_{tr,I}(x,E)
$$
\n(17)

and mixed Dirichlet-Neumann boundary conditions

$$
n(x,t) = n_D(x,t), \quad p(x,t) = p_D(x,t), \quad V(x,t) = V_D(x,t) \quad x \in \partial\Omega_D \subset \partial\Omega \tag{18}
$$

and

$$
\frac{\partial n}{\partial \nu}(x,t) = \frac{\partial p}{\partial \nu}(x,t) = \frac{\partial V}{\partial \nu}(x,t) = 0 \quad x \in \partial \Omega_N := \partial \Omega \setminus \partial \Omega_D,\tag{19}
$$

where ν is the unit outward normal vector along $\partial\Omega_N$. We permit the special cases that either $\partial\Omega_D$ or $\partial\Omega_N$ are empty. More precisely, we assume that either $\partial\Omega_D$ has positive $(d-1)$ -dimensional measure, or it is empty. In the second situation $(\partial \Omega_D)$ empty) we have to assume total charge neutrality, i.e.,

$$
\int_{\Omega} (n + \varepsilon n_{tr} - p - C) dx = 0, \quad \text{if } \partial \Omega = \partial \Omega_N. \tag{20}
$$

The potential is then only determined up to a (physically irrelevant) additive constant.

The following assumptions on the data will be used: For the boundary data

$$
n_D, p_D \in W_{loc}^{1,\infty}(\Omega \times \mathbb{R}_t^+), \quad V_D \in L_{loc}^{\infty}(\mathbb{R}_t^+, W^{1,6}(\Omega)), \tag{21}
$$

for the initial data

$$
n_I, p_I \in H^1(\Omega) \cap L^{\infty}(\Omega), \quad 0 \le f_{tr,I} \le 1,
$$
\n⁽²²⁾

$$
\int_{\Omega} (n_I + \varepsilon n_{tr}(f_{tr,I}) - p_I - C) dx = 0, \quad \text{if } \partial \Omega = \partial \Omega_N, \tag{23}
$$

for the doping profile

$$
C \in L^{\infty}(\Omega), \tag{24}
$$

for the recombination-generation rate constants

$$
n_0, p_0, \tau_n, \tau_p \in L^{\infty}((0, 1)), \quad \tau_n, \tau_p \ge \tau_{min} > 0.
$$
 (25)

With these assumptions, a local existence and uniqueness result for the problem (9) – (12) , (17) –(19) for fixed positive ε can be proven by a straightforward extension of the approach in [5] (see also [10]). In the following, local existence will be assumed, and we shall concentrate on obtaining bounds which guarantee global existence and which are uniform in ε as $\varepsilon \to 0$. For the sake of simplicity, we consider that the data in (21), (22) and (24) do not depend on ε ; of course, our strategy works dealing with sequences of data bounded in the mentioned spaces.

The following result is a generalization of [6, Lemma 3.1], where the case of homogeneous Neumann boundary conditions and vanishing recombination was treated. Our proof uses a similar approach.

Lemma 3.1. Let the assumptions (21) – (25) be satisfied. Then, the solution of (9) – (12) , (17)–(19) exists for all times and satisfies $n, p \in L^{\infty}_{loc}((0, \infty), L^{\infty}(\Omega)) \cap L^2_{loc}((0, \infty), H^1(\Omega))$ uniformly in ε as $\varepsilon \to 0$ as well as $0 \le f_{tr} \le 1$.

Proof. Global existence will be a consequence of the following estimates. Introducing the new variables $\tilde{n} = n - n_D$, $\tilde{p} = p - p_D$, $\tilde{C} = C - \varepsilon n_{tr} - n_D + p_D$ the equations (10)–(12) take the following form:

$$
\partial_t \widetilde{n} = \nabla \cdot J_n + R_n - \partial_t n_D, \quad J_n = \mu_n \left[\nabla \widetilde{n} + \nabla n_D - (\widetilde{n} + n_D) \nabla V \right], \tag{26}
$$

$$
\partial_t \widetilde{p} = -\nabla J_p + R_p - \partial_t p_D, \quad J_p = -\mu_p \left[\nabla \widetilde{p} + \nabla p_D + (\widetilde{p} + p_D) \nabla V \right],\tag{27}
$$

$$
\lambda^2 \Delta V = \tilde{n} - \tilde{p} - \tilde{C} \,. \tag{28}
$$

As a consequence of $0 \le f_{tr} \le 1$, $C \in L^{\infty}((0, \infty) \times \Omega)$ holds. For $q \ge 2$ and even, we multiply (26) by $\widetilde{n}^{q-1}/\mu_n$, (27) by $\widetilde{p}^{q-1}/\mu_p$, and add:

$$
\frac{d}{dt} \int_{\Omega} \left[\frac{\tilde{n}^{q}}{q\mu_{n}} + \frac{\tilde{p}^{q}}{q\mu_{p}} \right] dx = -(q-1) \int_{\Omega} \tilde{n}^{q-2} \nabla \tilde{n} \nabla n dx - (q-1) \int_{\Omega} \tilde{p}^{q-2} \nabla \tilde{p} \nabla p dx \n+ (q-1) \int_{\Omega} \left[\tilde{n}^{q-2} n \nabla \tilde{n} - \tilde{p}^{q-2} p \nabla \tilde{p} \right] \nabla V dx \n+ \int_{\Omega} \frac{\tilde{n}^{q-1}}{\mu_{n}} (R_{n} - \partial_{t} n_{D}) + \int_{\Omega} \frac{\tilde{p}^{q-1}}{\mu_{p}} (R_{p} - \partial_{t} p_{D}) \n=: I_{1} + I_{2} + I_{3} + I_{4} + I_{5}.
$$
\n(29)

Using the assumptions on n_D , p_D and $|R_n| \leq C(n+1)$, $|R_p| \leq C(p+1)$, we estimate

$$
I_4 \leq C \int_{\Omega} |\tilde{n}|^{q-1} (n+1) \, dx \leq C \left(\int_{\Omega} \tilde{n}^q \, dx + 1 \right), \quad I_5 \leq C \left(\int_{\Omega} \tilde{p}^q \, dx + 1 \right).
$$

The term I_3 can be rewritten as follows:

$$
I_3 = \int_{\Omega} \left[\tilde{n}^{q-1} \nabla \tilde{n} - \tilde{p}^{q-1} \nabla \tilde{p} \right] \nabla V \, dx
$$

+
$$
\int_{\Omega} \left[\tilde{n}^{q-2} \nabla \tilde{n} \right] (n_D \nabla V) \, dx - \int_{\Omega} \left[\tilde{p}^{q-2} \nabla \tilde{p} \right] (p_D \nabla V) \, dx
$$

=
$$
- \frac{1}{\lambda^2 q} \int_{\Omega} \left[\tilde{n}^q - \tilde{p}^q \right] (\tilde{n} - \tilde{p} - \tilde{C}) \, dx
$$

$$
- \frac{1}{\lambda^2 (q-1)} \int_{\Omega} \tilde{n}^{q-1} \left(\nabla n_D \nabla V + n_D (\tilde{n} - \tilde{p} - \tilde{C}) \right) \, dx
$$

+
$$
\frac{1}{\lambda^2 (q-1)} \int_{\Omega} \tilde{p}^{q-1} \left(\nabla p_D \nabla V + p_D (\tilde{n} - \tilde{p} - \tilde{C}) \right) \, dx.
$$

The second equality uses integration by parts and (28). The first term on the right hand side is the only term of degree $q + 1$. It reflects the quadratic nonlinearity of the problem. Fortunately, it can be written as the sum of a term of degree q and a nonnegative term. By estimation of the terms of degree q using the assumptions on n_D and p_D as well as $\|\nabla V\|_{L^q(\Omega)} \leq C(\|\tilde{n}\|_{L^q(\Omega)} + \|\tilde{p}\|_{L^q(\Omega)} + \|\tilde{C}\|_{L^q(\Omega)}),$ we obtain

$$
I_3 \leq -\frac{1}{\lambda^2 q} \int_{\Omega} \left[\tilde{n}^q - \tilde{p}^q \right] (\tilde{n} - \tilde{p}) dx + C \left(\int_{\Omega} (\tilde{n}^q + \tilde{p}^q) dx + 1 \right)
$$

$$
\leq C \left(\int_{\Omega} (\tilde{n}^q + \tilde{p}^q) dx + 1 \right).
$$

The integral I_1 can be written as

$$
I_1 = -\int_{\Omega} \widetilde{n}^{q-2} |\nabla n|^2 dx + \int_{\Omega} \widetilde{n}^{q-2} \nabla n_D \nabla n \, dx. \tag{30}
$$

By rewriting the integrand in the second integral as

$$
\widetilde{n}^{q-2} \nabla n_D \nabla n = \widetilde{n}^{\frac{q-2}{2}} \nabla n \widetilde{n}^{\frac{q-2}{2}} \nabla n_D
$$

and applying the Cauchy-Schwarz inequality, we have the following estimate for (30):

$$
I_1 \leq -\int_{\Omega} \widetilde{n}^{q-2} |\nabla n|^2 dx + \sqrt{\int_{\Omega} \widetilde{n}^{q-2} |\nabla n|^2 dx \int_{\Omega} \widetilde{n}^{q-2} |\nabla n_D|^2 dx}
$$

$$
\leq -\frac{1}{2} \int_{\Omega} \widetilde{n}^{q-2} |\nabla n|^2 dx + C ||\widetilde{n}||_{L^q}^{q-2} \leq -\frac{1}{2} \int_{\Omega} \widetilde{n}^{q-2} |\nabla n|^2 dx + C \left(\int_{\Omega} \widetilde{n}^q dx + 1 \right).
$$

For I_2 , the same reasoning (with n and n_D replaced by p and p_D , respectively) yields an analogous estimate. Collecting our results, we obtain

$$
\frac{d}{dt} \int_{\Omega} \left[\frac{\tilde{n}^q}{q \mu_n} + \frac{\tilde{p}^q}{q \mu_p} \right] dx \le -\frac{1}{2} \int_{\Omega} \tilde{n}^{q-2} |\nabla n|^2 dx - \frac{1}{2} \int_{\Omega} \tilde{p}^{q-2} |\nabla p|^2 dx \n+ C \left(\int_{\Omega} (\tilde{n}^q + \tilde{p}^q) dx + 1 \right).
$$
\n(31)

Since $q \geq 2$ is even, the first two terms on the right hand side are nonpositive and the Gronwall lemma gives

$$
\int_{\Omega} (\widetilde{n}^q + \widetilde{p}^q) dx \le e^{qCt} \left(\int_{\Omega} (\widetilde{n}(t=0)^q + \widetilde{p}(t=0)^q) dx + 1 \right) .
$$

A uniform-in-q-and- ε estimate for $||n||_{Lq}$, $||p||_{Lq}$ follows, and the uniform-in- ε bound in $L^{\infty}_{loc}((0,\infty), L^{\infty}(\Omega))$ is obtained in the limit $q \to \infty$. The estimate in $L^2_{loc}((0,\infty), H^1(\Omega))$ is then derived by returning to (31) with $q = 2$. \Box

Now we are ready for proving the main result of this section.

Theorem 3.2. Let the assumptions of Theorem 3.1 be satisfied. Then, as $\varepsilon \to 0$, for every $T > 0$, the solution (f_{tr}, n, p, V) of (9) - (12) , (17) - (19) converges with convergence of f_{tr} in $L^{\infty}((0,T) \times \Omega \times (0,1))$ weak*, n and p in $L^2((0,T) \times \Omega)$, and V in $L^2((0,T), H^1(\Omega))$. The limits of n, p, and V satisfy (13) – (19) .

Proof. The L^{∞} -bounds for f_{tr} , n, and p, and the Poisson equation (12) imply $\nabla V \in$ $L^2((0,T)\times\Omega)$. From the definition of J_n,J_p (see (4),(5)), it then follows that $J_n,J_p \in$ $L^2((0,T)\times\Omega)$. Then (10) and (11) together with $R_n, R_p \in L^\infty((0,T)\times\Omega)$ imply $\partial_t n, \partial_t p \in L^\infty((0,T)\times\Omega)$. $L^2((0,T),H^{-1}(\Omega))$. The previous result and the Aubin lemma (see, e.g., Simon [14, Corollary 4, p. 85]) gives compactness of *n* and *p* in $L^2((0,T) \times \Omega)$.

We already know from the Poisson equation that $\nabla V \in L^{\infty}((0,T), H^{1}(\Omega))$. By taking the time derivative of (12), one obtains

$$
\partial_t \Delta V = \nabla \cdot (J_n + J_p),
$$

with the consequence that $\partial_t \nabla V$ is bounded in $L^2((0,T) \times \Omega)$. Therefore, the Aubin lemma can again be applied as above to prove compactness of ∇V in $L^2((0,T) \times \Omega)$.

These results and the weak compactness of f_{tr} are sufficient for passing to the limit in the nonlinear terms $n\nabla V$, $p\nabla V$, nf_{tr} , and pf_{tr} . Let us also remark that $\partial_t n$ and $\partial_t p$ are bounded in $L^2(0,T;H^{-1}(\Omega))$, so that n, p are compact in $C^0([0,T];L^2(\Omega) - weak)$. With this remark the initial data for the limit equation makes sense. By the uniqueness result for the limiting problem (mentioned at the end of Section 2), the convergence is not restricted to subsequences. \Box

4 A kinetic Shockley-Read-Hall model

In this section we replace the drift-diffusion model for electrons and holes by a semiclassical kinetic transport model. It is governed by the system

$$
\partial_t f_n + v_n(k) \cdot \nabla_x f_n + \frac{q}{\hbar} \nabla_x V \cdot \nabla_k f_n = Q_n(f_n) + Q_{n,r}(f_n, f_{tr}), \tag{32}
$$

$$
\partial_t f_p + v_p(k) \cdot \nabla_x f_p - \frac{q}{\hbar} \nabla_x V \cdot \nabla_k f_p = Q_p(f_p) + Q_{p,r}(f_p, f_{tr}),\tag{33}
$$

$$
\partial_t f_{tr} = S_p(f_p, f_{tr}) - S_n(f_n, f_{tr}),\tag{34}
$$

$$
\varepsilon_s \Delta_x V = q(n + n_{tr} - p - C),\tag{35}
$$

where $f_i(x, k, t)$ represents the particle distribution function (with $i = n$ for electrons and $i = p$ for holes) at time $t \geq 0$, at the position $x \in \mathbb{R}^3$, and at the wave vector (or generalized momentum) $k \in \mathbb{R}^3$. All functions of k have the periodicity of the reciprocal lattice of the semiconductor crystal. Equivalently, we shall consider only $k \in B$, where B is the Brillouin zone, i.e., the set of all k which are closer to the origin than to any other lattice point, with periodic boundary conditions on ∂B.

The coefficient functions $v_n(k)$ and $v_n(k)$ denote the electron and hole velocities, respectively, which are related to the electron and hole band diagrams by

$$
v_n(k) = \nabla_k \varepsilon_n(k)/\hbar, \quad v_p(k) = -\nabla_k \varepsilon_p(k)/\hbar,
$$

where \hbar is the reduced Planck constant. The elementary charge is still denoted by q.

The collision operators Q_n and Q_p describe the interactions between the particles and the crystal lattice. They involve several physical phenomena and can be written in the general form

$$
Q_n(f_n) = \int_B \widetilde{\Phi}_n(k, k') [M_n f'_n (1 - f_n) - M'_n f_n (1 - f'_n)] dk', \tag{36}
$$

$$
Q_p(f_p) = \int_B \widetilde{\Phi}_p(k, k') [M_p f'_p (1 - f_p) - M'_p f_p (1 - f'_p)] dk', \tag{37}
$$

with the primes denoting evaluation at k' , with the nonnegative, symmetric scattering cross sections $\Phi_n(k, k')$ and $\Phi_p(k, k')$, and with the Maxwellians

$$
M_n(k) = c_n \exp(-\varepsilon_n(k)/k_B T), \quad M_p(k) = c_p \exp(-\varepsilon_p(k)/k_B T),
$$

where k_BT is the thermal energy of the semiconductor crystal lattice and the constants c_n , c_p are chosen such that

$$
\int_B M_n \, dk = \int_B M_p \, dk = 1.
$$

The remaining collision operators $Q_{n,r}(f_n, f_{tr})$ and $Q_{p,r}(f_p, f_{tr})$ model the generation and recombination processes and are given by

$$
Q_{n,r}(f_n, f_{tr}) = \int_{E_v}^{E_c} \hat{S}_n(f_n, f_{tr}) M_{tr} dE , \qquad (38)
$$

with

$$
\hat{S}_n(f_n, f_{tr}) = \frac{\Phi_n(k, E)}{N_{tr}} [n_0 M_n f_{tr} (1 - f_n) - f_n (1 - f_{tr})],
$$

and

$$
Q_{p,r}(f_p, f_{tr}) = \int_{E_v}^{E_c} \hat{S}_p(f_p, f_{tr}) M_{tr} dE , \qquad (39)
$$

with

$$
\hat{S}_p(f_p, f_{tr}) = \frac{\Phi_p(k, E)}{N_{tr}} [p_0 M_p (1 - f_p)(1 - f_{tr}) - f_p f_{tr}],
$$

and where $\Phi_{n,p}$ are non negative and $M_{tr}(x, E)$ is the density of available trapped states as for the drift diffusion model, except that we allow for a position dependence now. This will be commented on below. The parameter N_{tr} is now determined as $N_{tr} = \sup_{x \in \mathbb{R}^3} \int_0^1 M_{tr}(x, E) dE$.

The right hand side in the equation for the occupancy $f_{tr}(x, E, t)$ of the trapped states is defined by

$$
S_n(f_n, f_{tr}) = \int_B \hat{S}_n \, dk = \lambda_n [n_0 M_n (1 - f_n)] f_{tr} - \lambda_n [f_n] (1 - f_{tr}), \tag{40}
$$

with $\lambda_n[g] = \int_B \Phi_n g \, dk$, and

$$
S_p(f_p, f_{tr}) = \int_B \hat{S}_p \, dk = \lambda_p [p_0 M_p (1 - f_p)] (1 - f_{tr}) - \lambda_p [f_p] f_{tr}, \tag{41}
$$

with $\lambda_p[g] = \int_B \Phi_p g \, dk$.

The factors $(1 - f_n)$ and $(1 - f_p)$ take into account the Pauli exclusion principle, which therefore manifests itself in the requirement that the values of the distribution function have to respect the bounds $0 \leq f_n, f_p \leq 1$.

The position densities on the right hand side of the Poisson equation (35) are given by

$$
n(x,t) = \int_B f_n dk, \quad p(x,t) = \int_B f_p dk, \quad n_{tr}(x,t) = \int_{E_v}^{E_c} f_{tr} M_{tr} dE.
$$

The following scaling, which is strongly related to the one used for the drift-diffusion model, will render the equations (32) - (35) dimensionless:

Scaling of parameters:

- i. $M_{tr} \rightarrow \frac{N_{tr}}{E_v E_c} M_{tr}$, ii. $(\varepsilon_n, \varepsilon_p) \to k_BT(\varepsilon_n, \varepsilon_p)$, with the thermal energy k_BT ,
- iii. $(\Phi_n, \Phi_p) \to \tau_{rg}^{-1}(\Phi_n, \Phi_p)$, where τ_{rg} is a typical carrier life time,

$$
\mathbf{iv.} \ \ (\widetilde{\Phi}_n, \widetilde{\Phi}_p) \to \tau_{coll}^{-1}(\widetilde{\Phi}_n, \widetilde{\Phi}_p),
$$

v. $(n_0, p_0, C) \rightarrow \overline{C}(n_0, p_0, C)$, where \overline{C} is a typical value of $|C|$,

vi. $(M_n, M_p) \rightarrow \overline{C}^{-1}(M_n, M_p).$

Scaling of independent variables:

$$
\begin{aligned}\n\textbf{vii.} \quad &x \to k_B T \sqrt{\tau_{rg} \tau_{coll}} \overline{C}^{-1/3} \hbar^{-1} \, x, \\
\textbf{viii.} \quad &t \to \tau_{rg} t, \\
\textbf{ix.} \quad &k \to \overline{C}^{1/3} k, \\
\textbf{x.} \quad & E \to E_v + (E_c - E_v) E,\n\end{aligned}
$$

Scaling of unknowns:

$$
\mathbf{xi.} \ \ (f_n, f_p, f_{tr}) \rightarrow (f_n, f_p, f_{tr}),
$$

xii. $V \rightarrow U_T V$, with the thermal voltage $U_T = k_B T / q$.

Dimensionless parameters:

$$
\begin{aligned}\n\textbf{xiii.} \ \ \alpha^2 &= \frac{\tau_{coll}}{\tau_{rg}}, \\
\textbf{xiv.} \ \ \lambda &= \frac{\hbar}{q\sqrt{\tau_{rg}\tau_{coll}}\overline{C}^{1/6}}\sqrt{\frac{\varepsilon_s}{k_BT}},\n\end{aligned}
$$

xv. $\varepsilon = \frac{N_{tr}}{\overline{C}}$ $\frac{N_{tr}}{C}$, where again we shall study the situation $\varepsilon \ll 1$.

Finally, the scaled system reads

$$
\alpha^2 \partial_t f_n + \alpha v_n(k) \cdot \nabla_x f_n + \alpha \nabla_x V \cdot \nabla_k f_n = Q_n(f_n) + \alpha^2 Q_{n,r}(f_n, f_{tr}),\tag{42}
$$

$$
\alpha^2 \partial_t f_p + \alpha v_p(k) \cdot \nabla_x f_p - \alpha \nabla_x V \cdot \nabla_k f_p = Q_p(f_p) + \alpha^2 Q_{p,r}(f_p, f_{tr}),\tag{43}
$$

$$
\varepsilon \partial_t f_{tr} = S_p(f_p, f_{tr}) - S_n(f_n, f_{tr}), \qquad (44)
$$

$$
\lambda^2 \Delta_x V = n + \varepsilon n_{tr} - p - C = -\rho,\tag{45}
$$

with $v_n = \nabla_k \varepsilon_n$, $v_p = -\nabla_k \varepsilon_p$, with Q_n and Q_p still having the form (36) and, respectively, (37), with the scaled Maxwellians

$$
M_n(k) = c_n \exp(-\varepsilon_n(k)), \qquad M_p(k) = c_p \exp(-\varepsilon_p(k)), \qquad (46)
$$

and with the recombination-generation terms

$$
Q_{n,r}(f_n, f_{tr}) = \int_0^1 \hat{S}_n M_{tr} dE, \qquad Q_{p,r}(f_p, f_{tr}) = \int_0^1 \hat{S}_p M_{tr} dE, \qquad (47)
$$

with

$$
\hat{S}_n = \Phi_n[n_0 M_n f_{tr}(1 - f_n) - f_n(1 - f_{tr})], \quad \hat{S}_p = \Phi_p[p_0 M_p (1 - f_{tr})(1 - f_p) - f_p f_{tr}]. \tag{48}
$$

The right hand side of (44) still has the form (40), (41). The position densities are given by

$$
n = \int_{B} f_n \, dk \,, \qquad p = \int_{B} f_p \, dk \,, \qquad n_{tr} = \int_{0}^{1} f_{tr} M_{tr} \, dE \,. \tag{49}
$$

The system (42)–(44) conserves the total charge $\rho = p + C - n - \varepsilon n_{tr}$. With the definition

$$
J_n = -\frac{1}{\alpha} \int_B v_n f_n \, dk \,, \quad J_p = \frac{1}{\alpha} \int_B v_p f_p \, dk \,,
$$

of the current densities, the following continuity equation holds formally:

$$
\partial_t \rho + \nabla_x \cdot (J_n + J_p) = 0 \, .
$$

Setting formally $\varepsilon = 0$ in (44) we obtain

$$
\overline{f}_{tr}(f_n, f_p) = \frac{p_0 \lambda_p [M_p(1 - f_p)] + \lambda_n [f_n]}{p_0 \lambda_p [M_p(1 - f_p)] + \lambda_p [f_p] + \lambda_n [f_n] + n_0 \lambda_n [M_n(1 - f_n)]}
$$

Substitution \overline{f}_{tr} into (47) leads to the kinetic Shockley-Read-Hall recombination-generation operators

$$
\overline{Q}_{n,r}(f_n, f_p) = \overline{g}_n[f_n, f_p](1 - f_n) - \overline{r}_n[f_n, f_p]f_n, \qquad \overline{Q}_{p,r}(f_n, f_p) = \overline{g}_p[f_n, f_p](1 - f_p) - \overline{r}_p[f_n, f_p]f_p,
$$
\n(50)

with

$$
\overline{g}_n = \int_0^1 \frac{\Phi_n M_n n_0 \Big(p_0 \lambda_p [M_p (1 - f_p)] + \lambda_n [f_n] \Big) M_{tr}}{p_0 \lambda_p [M_p (1 - f_p)] + \lambda_p [f_p] + \lambda_n [f_n] + n_0 \lambda_n [M_n (1 - f_n)]} dE,
$$
\n
$$
\overline{r}_n = \int_0^1 \frac{\Phi_n \Big(\lambda_p [f_p] + n_0 \lambda_n [M_n (1 - f_n)] \Big) M_{tr}}{p_0 \lambda_p [M_p (1 - f_p)] + \lambda_p [f_p] + \lambda_n [f_n] + n_0 \lambda_n [M_n (1 - f_n)]} dE,
$$
\n
$$
\overline{g}_p = \int_0^1 \frac{\Phi_p M_p p_0 \Big(n_0 \lambda_n [M_n (1 - f_n)] + \lambda_p [f_p] \Big) M_{tr}}{p_0 \lambda_p [M_p (1 - f_p)] + \lambda_p [f_p] + \lambda_n [f_n] + n_0 \lambda_n [M_n (1 - f_n)]} dE,
$$
\n
$$
\overline{r}_p = \int_0^1 \frac{\Phi_p \Big(\lambda_n [f_n] + p_0 \lambda_p [M_p (1 - f_p)] \Big) M_{tr}}{p_0 \lambda_p [M_p (1 - f_p)] + \lambda_p [f_p] + \lambda_n [f_n] + n_0 \lambda_n [M_n (1 - f_n)]} dE.
$$

Of course, the limiting model still conserves charge, which is expressed by the identity

$$
\int_B \overline{Q}_{n,r} \, dk = \int_B \overline{Q}_{p,r} \, dk \, .
$$

Pairs of electrons and holes are generated or recombine, however, in general not with the same wave vector. This absence of momentum conservation is reasonable since the process involves an interaction with the trapped states fixed within the crystal lattice.

5 Rigorous derivation of the kinetic Shockley-Read-Hall model

The limit $\varepsilon \to 0$ will be carried out rigorously in an initial value problem for the kinetic model with $x \in \mathbb{R}^3$. Concerning the behaviour for $|x| \to \infty$, we shall require the densities to be in L^1 and use the Newtonian potential solution of the Poisson equation, i.e., (45) will be replaced by

$$
\mathcal{E}(x,t) = -\nabla_x V = \lambda^{-2} \int_{\mathbb{R}^3} \frac{x-y}{|x-y|^3} \rho(y,t) dy.
$$
 (51)

We define **Problem (K)** as the system (42) – (44) , (51) with (36) , (37) , (47) – (49) , (40) , and (41), subject to the initial conditions

$$
f_n(x, k, 0) = f_{n,I}(x, k), \quad f_p(x, k, 0) = f_{p,I}(x, k), \quad f_{tr}(x, E, 0) = f_{tr,I}(x, E).
$$

We start by stating our assumptions on the data. For the velocities we assume

$$
v_n, v_p \in W_{per}^{1,\infty}(B), \tag{52}
$$

where here and in the following, the subscript per denotes Sobolev spaces of functions of k satisfying periodic boundary conditions on ∂B . Further we assume that the cross sections satisfy

$$
\widetilde{\Phi}_n, \widetilde{\Phi}_p \ge 0, \quad \widetilde{\Phi}_n, \widetilde{\Phi}_p \in W_{per}^{1,\infty}(B \times B), \tag{53}
$$

and

$$
\Phi_n, \Phi_p \ge 0 \,, \quad \Phi_n, \Phi_n \in W_{per}^{1,\infty}(B \times (0,1)) \,. \tag{54}
$$

A finite total number of trapped states is assumed:

 $M_{tr} \geq 0$, $M_{tr} \in W^{1,\infty}(\mathbb{R}^3 \times (0,1)) \cap W^{1,1}(\mathbb{R}^3 \times (0,1))$.

The L^1 -assumption with respect to x is needed for controlling the total number of generated particles. For the initial data we assume

$$
0 \le f_{n,I}, f_{p,I} \le 1, \quad f_{n,I}, f_{p,I} \in W_{per}^{1,\infty}(\mathbb{R}^3 \times B) \cap W_{per}^{1,1}(\mathbb{R}^3 \times B),
$$

\n
$$
0 \le f_{tr,I} \le 1, \quad f_{tr,I} \in W_{per}^{1,\infty}(\mathbb{R}^3 \times (0,1)).
$$
\n(55)

We also assume

$$
n_0, p_0 \in L^{\infty}((0,1)), \qquad C \in W^{1,\infty}(\mathbb{R}^3) \cap W^{1,1}(\mathbb{R}^3).
$$
 (56)

Finally, we need an upper bound for the life time of trapped electrons:

$$
\int_{B} \left(\Phi_n \min\{1, n_0 M_n\} + \Phi_p \min\{1, p_0 M_p\} \right) dk \ge \gamma > 0. \tag{57}
$$

The reason for the various differentiability assumptions above is that we shall construct smooth solutions by an approach along the lines of $[11]$, which goes back to $[4]$.

An essential tool are the following potential theory estimates [15]:

$$
\|\mathcal{E}\|_{L^{\infty}(\mathbb{R}^3)} \le C \|\rho\|_{L^1(\mathbb{R}^3)}^{1/3} \|\rho\|_{L^{\infty}(\mathbb{R}^3)}^{2/3},\tag{58}
$$

$$
\|\nabla_x \mathcal{E}\|_{L^{\infty}(\mathbb{R}^3)} \le C\left(1 + \|\rho\|_{L^1(\mathbb{R}^3)} + \|\rho\|_{L^{\infty}(\mathbb{R}^3)}\left[1 + \log(1 + \|\nabla_x \rho\|_{L^{\infty}(\mathbb{R}^3)})\right]\right). \tag{59}
$$

We start by rewriting the collision and recombination generation operators as

$$
Q_i(f_i) = a_i[f_i](1 - f_i) - b_i[f_i]f_i, \quad i = n, p,
$$

and

$$
Q_{i,r}(f_i, f_{tr}) = g_i[f_{tr}](1 - f_i) - r_i[f_{tr}]f_i, \quad i = n, p,
$$

with

$$
a_i[f_i] = \int_B \widetilde{\Phi}_i M_i f'_i dk', \quad b_i[f_i] = \int_B \widetilde{\Phi}_i M'_i (1 - f'_i) dk', \quad i = n, p
$$

$$
g_n[f_{tr}] = \int_0^1 \Phi_n n_0 M_n f_{tr} M_{tr} dE, \quad g_p[f_{tr}] = \int_0^1 \Phi_p p_0 M_p (1 - f_{tr}) M_{tr} dE,
$$

$$
r_n[f_{tr}] = \int_0^1 \Phi_n (1 - f_{tr}) M_{tr} dE, \quad r_p[f_{tr}] = \int_0^1 \Phi_p f_{tr} M_{tr} dE.
$$

In order to construct an approximating sequence $(f_n^j, f_p^j, f_{tr}^j, \mathcal{E}^j)$ we begin with

$$
f_i^0(x, k, t) = f_{i,I}(x, k), \quad i = n, p, \quad f_{tr}^0(x, E, t) = f_{tr,I}(x, E)
$$
(60)

The field always satisfies

$$
\mathcal{E}^j(x,t) = \int_{\mathbb{R}^3} \frac{x-y}{|x-y|^3} \rho^j(y,t) \, dy \tag{61}
$$

Let $(f_n^j, f_p^j, f_{tr}^j, \mathcal{E}^j)$ be given. Then the f_i^{j+1} are defined as the solutions of the following problem:

$$
\alpha^{2}\partial_{t}f_{n}^{j+1} + \alpha v_{n}(k) \cdot \nabla_{x}f_{n}^{j+1} - \alpha \mathcal{E}^{j} \cdot \nabla_{k}f_{n}^{j+1}
$$
\n
$$
= (a_{n}[f_{n}^{j}] + \alpha^{2}g_{n}[f_{tr}^{j}]) (1 - f_{n}^{j+1}) - (b_{n}[f_{n}^{j}] + \alpha^{2}r_{n}[f_{tr}^{j}])f_{n}^{j+1},
$$
\n
$$
\alpha^{2}\partial_{t}f_{p}^{j+1} + \alpha v_{p}(k) \cdot \nabla_{x}f_{p}^{j+1} + \alpha \mathcal{E}^{j} \cdot \nabla_{k}f_{p}^{j+1}
$$
\n
$$
= (a_{p}[f_{p}^{j}] + \alpha^{2}g_{p}[f_{tr}^{j}]) (1 - f_{p}^{j+1}) - (b_{p}[f_{p}^{j}] + \alpha^{2}r_{p}[f_{tr}^{j}])f_{p}^{j+1},
$$
\n
$$
\varepsilon \partial_{t}f_{tr}^{j+1} = (p_{0}\lambda_{p}[M_{p}(1 - f_{p}^{j})] + \lambda_{n}[f_{n}^{j}]) (1 - f_{tr}^{j+1}) - (n_{0}\lambda_{n}[M_{n}(1 - f_{n}^{j})] + \lambda_{p}[f_{p}^{j}])f_{tr}^{j+1},
$$
\n(62)

subject to the initial conditions

$$
f_n^{j+1}(x, k, 0) = f_{n,I}(x, k), \quad f_p^{j+1}(x, k, 0) = f_{p,I}(x, k), \quad f_{tr}^{j+1}(x, E, 0) = f_{tr,I}(x, E). \tag{63}
$$

For the iterative sequence we state the following lemma, which is very similar to the Proposition 3.1 from $[11]$:

Lemma 5.1. Let the assumptions (52)–(56) be satisfied. Then the sequence $(f_n^j, f_p^j, f_{tr}^j, \mathcal{E}^j)$, defined by (60)-(63) satisfies for any time $T > 0$

- **a**) $0 \le f_i^j \le 1, i = n, p, tr.$
- b) f_n^j and f_p^j are uniformly bounded with respect to $j \to \infty$ and $\varepsilon \to 0$ in $L^{\infty}((0,T), L^1(\mathbb{R}^3 \times$ B).
- c) \mathcal{E}^j is uniformly bounded with respect to j and ε in $L^{\infty}((0,T) \times \mathbb{R}^3)$.

Proof. The first two equations in (62) are standard linear transport equations, and the third equation is a linear ODE. Existence and uniqueness for the initial value problems are therefore standard results.

Note that the a_i , b_i , g_i , r_i , and λ_i in (62) are nonnegative if we assume that a) holds for j. Then a) for $j + 1$ is an immediate consequence of the maximum principle.

To estimate the L^1 -norms of the distributions, we integrate the first equation in (62) and obtain

$$
||f_n^{j+1}||_{L^1(\mathbb{R}^3 \times B)} \le ||f_{n,I}||_{L^1(\mathbb{R}^3 \times B)} + \int_0^t ||a_n[f_n^j] \frac{1}{\alpha^2} + g_n[f_n^j]||_{L^1(\mathbb{R}^3 \times B)}(s) ds. \tag{64}
$$

The boundedness of $\widetilde{\Phi}_n$, Φ_n , and f_{tr}^j , and the integrability of M_{tr} imply

$$
||a_n[f_n^j]||_{L^1(\mathbb{R}^3 \times B)} \le C ||f_n^j||_{L^1(\mathbb{R}^3 \times B)}, \quad ||g_n[f_{tr}^j]||_{L^1(\mathbb{R}^3 \times B)} \le C. \tag{65}
$$

Now this is used in (64). Then an estimate is derived for f_n^j by replacing $j + 1$ by j and using the Gronwall inequality. Finally, it is easily since that this estimate is passed from j to $j+1$ by (64). An analogous argument for f_p^j completes the proof of b).

A uniform-in- ε $(L^1 \cap L^{\infty})$ -bound for the total charge density $\rho^j = n^j + \varepsilon n^j_t - p^j - C$ follows from b) and from the integrability of M_{tr} . The statement c) of the lemma is now a consequence of (58). \Box

For passing to the limit in the nonlinear terms some compactness is needed. Therefore we prove uniform smoothness of the approximating sequence.

Lemma 5.2. Let the assumptions (52)–(57) be satisfied. Then for any time $T > 0$:

- a) f_n^j and f_p^j are uniformly bounded with respect to j and ε in $L^{\infty}((0,T), W^{1,1}_{per}(\mathbb{R}^3 \times B) \cap$ $W_{per}^{1,\infty}(\mathbb{R}^3 \times B)),$
- b) f_{tr}^j is uniformly bounded with respect to j and ε in $L^{\infty}((0,T), W^{1,\infty}(\mathbb{R}^3 \times (0,1))),$
- c) \mathcal{E}^j is uniformly bounded with respect to j and ε in $L^{\infty}((0,T), W_{1,\infty}(\mathbb{R}^3))$.

Proof. We start by introducing $\nu^j = \nabla_{x,k} f_n^j = (\nu_x^j, \nu_k^j)$ (π_k^j) , $\pi^j = \nabla_{x,k} f_p^j = (\pi_x^j, \pi_k^j)$ ϕ^j_k , $\phi^j = \nabla_x f^j_{tt}$ tr and by differentiating the last equation in (62) with respect to x:

$$
\varepsilon \partial_t \phi^{j+1} = (-p_0 \lambda_p [M_p \pi_x^j] + \lambda_n [\nu_x^j])(1 - f_{tr}^{j+1}) - (-n_0 \lambda_n [M_n \nu_x^j] + \lambda_p [\pi_x^j]) f_{tr}^{j+1} - (p_0 \lambda_p [M_p (1 - f_p^j]) + \lambda_n [f_n^j] + n_0 \lambda_n [M_n (1 - f_n^j)] + \lambda_p [f_p^j]) \phi^{j+1}.
$$

The coefficient of ϕ^{j+1} on the right hand side is bounded below by the term appearing in assumption (57) and, thus, bounded away from zero. The maximum principle implies

$$
\sup_{(0,t)} \|\phi^{j+1}\|_{\infty} \leq C \left(\sup_{(0,t)} \|\nu_x^j\|_{\infty} + \sup_{(0,t)} \|\pi_x^j\|_{\infty} + 1 \right),
$$

where here and in the following we use the symbol $\|\cdot\|_{\infty}$ for the L^{∞} -norm on \mathbb{R}^3 , on $\mathbb{R}^3 \times B$ and on $\mathbb{R}^3 \times (0,1)$. The gradient of the first equation in (62) with respect to x and k can be written as

$$
\alpha^2 \partial_t \nu^{j+1} + \alpha v_n \cdot \nabla_x \nu^{j+1} - \alpha \mathcal{E}^j \cdot \nabla_k \nu^{j+1} + (a_n + b_n + \alpha^2 g_n + \alpha^2 r_n) \nu^{j+1} = S_n^j,
$$

where it is easily seen that, using our assumptions,

$$
||S_n^j||_{\infty} \le C \left(1 + ||\nu^j||_{\infty} + ||\phi^j||_{\infty} + ||\nu^{j+1}||_{\infty} (1 + ||\nabla_x \mathcal{E}^j||_{\infty}) \right)
$$

holds. The analogous treatment of the second equation in (62), the potential theory inequality (59), and the definition

$$
\gamma^{j}(t) = \sup_{(0,t)} (\|\nu^{j}\|_{\infty} + \|\pi^{j}\|_{\infty} + \|\phi^{j}\|_{\infty})
$$

lead to

$$
\gamma^{j+1} \le C \left(1 + \int_0^t (\gamma^j + \gamma^{j+1} (1 + \log(1 + \gamma^j)) ds \right)
$$

implying boundedness of γ^j on arbitrary bounded time intervals (as in [4]). This proves c) and the L[∞]-part of a). The equation for $\partial_E f_{tr}^{j+1}$ can be treated as above completing the proof of b).

By $\int_{\mathbb{R}^3} n_{tr} dx \leq \int_{\mathbb{R}^3} M_{tr} dx$, it is trivial that the total number of trapped electrons is bounded. Therefore, the L^1 -estimates in a) follow the line of [11]) since no coupling with the equation for the trapped electrons is necessary. \Box

With the previous results, the first two equations in (62) also give uniform bounds for the time derivatives of f_n^j and f_p^j . Thus, subsequences converge strongly locally in x and t. In the same way, the right hand side of the time derivative of the Poisson equation is bounded in L^1 and in L^{∞} , and (58) implies boundedness of the time derivative of the field. So the field also converges strongly. This and the (obvious) weak convergence of f_{tr}^j are sufficient for passing to the limit in the quadratic nonlinearities. Note also that we have enough bounds on time derivative to define the trace at time $t = 0$. Existence of a global solution of Problem (K) follows. By the same argument, however, the limit $\varepsilon \to 0$ can be justified, since all estimates are also uniform in ε .

Theorem 5.3. Let the assumptions (52) – (57) be satisfied. Then Problem (K) has a global solution $(f_n, f_p, f_{tr}, \mathcal{E})$ with $f_n, f_p \in L^{\infty}_{loc}((0, \infty), W^{1,\infty}_{per}(\mathbb{R}^3 \times B))$, $f_{tr} \in L^{\infty}_{loc}((0, \infty), W^{1,\infty}(\mathbb{R}^3 \times B))$ $(0,1))$, $\mathcal{E} \in L^{\infty}_{loc}((0,\infty),W^{1,\infty}(\mathbb{R}^3))$. For $\varepsilon \to 0$, a subsequence of solutions converges to the formal limit problem. The convergence of f_n and f_p is in $L^{\infty}_{loc}((0,\infty) \times \mathbb{R}^3 \times B)$, that of $\mathcal E$ in $L^{\infty}_{loc}((0,\infty)\times\mathbb{R}^3)$ and that of f_{tr} in $L^{\infty}_{loc}((0,\infty)\times\mathbb{R}^3\times(0,1))$ weak*.

6 Relation between macroscopic and kinetic models

In this section the relation between the two models in Sections 2 and 4 are clarified on a formal level. The drift-diffusion model of Section 2 can be derived from the kinetic model of Section 4 by two simplification steps: a macroscopic and a low density limit.

Starting with the macroscopic limit, i.e., the limit when the Knudsen number α tends to zero in (42), (43), the solutions are expanded in terms of powers of α :

$$
f_n = f_n^0 + \alpha f_n^1 + \mathcal{O}(\alpha^2) , \qquad f_p = f_p^0 + \alpha f_p^1 + \mathcal{O}(\alpha^2) , \tag{66}
$$

$$
f_{tr} = f_{tr}^0 + \mathcal{O}(\alpha), \qquad V = V^0 + \mathcal{O}(\alpha). \tag{67}
$$

The limit of (42), (43) as $\alpha \to 0$ leads to $Q_n(f_n^0) = Q_p(f_p^0) = 0$. With the (frequently used) simplifying assumption that the cross sections $\widetilde{\Phi}_n$ and $\widetilde{\Phi}_p$ are strictly positive, the limiting distributions are of Fermi-Dirac type (see [11]):

$$
f_n^0(x, k, t) = \frac{1}{1 + e^{-\mu_n(x, t)} / M_n(k)}, \qquad f_p^0(x, k, t) = \frac{1}{1 + e^{\mu_p(x, t)} / M_p(k)},
$$

where the scaled Maxwellians M_n , M_p are given by (46), and the chemical potentials μ_n and μ_p are yet to be specified. Note the one-to-one relations between the chemical potentials and the macroscopic electron and hole densities:

$$
n(\mu_n) = \int_B \frac{dk}{1 + e^{-\mu_n}/M_n(k)}, \qquad p(\mu_p) = \int_B \frac{dk}{1 + e^{\mu_p}/M_p(k)}
$$

Now (42) is divided by α , and then again the limit $\alpha \to 0$ is carried out (formally):

$$
v_n \cdot \nabla_x f_n^0 + \nabla_x V^0 \cdot \nabla_k f_n^0 = L Q_n(f_n^0) f_n^1, \qquad (68)
$$

.

.

where LQ_n is the linearization of Q_n :

$$
LQ_n(f_n^0)f_n^1 = \int_B \widetilde{\Phi}_n \left[(M_n(1 - f_n^0) + M_n' f_n^0) f_n^{1'} - (M_n f_n^{0'} + M_n' (1 - f_n^{0'})) f_n^1 \right] dk'
$$

For the following we shall need two facts about the linearized collision operator $LQ_n(f_n^0)$ (see, e.g., [1]): It has a one dimensional kernel spanned by $f_n^0(1-f_n^0)$, and its range consists of functions whose integral with respect to k vanishes. Therefore, for solvability of (68) , seen as an equation for f_n^1 , the integral with respect to k of the left hand side has to vanish. This

is obvious for the second term $\nabla_x V^0 \cdot \nabla_k f_n^0$ by the periodicity with respect to k. Since the first term can be written as

$$
v_n \cdot \nabla_x f_n^0 = \nabla_k \varepsilon_n \cdot \nabla_x \frac{M_n}{M_n + e^{-\mu_n}} = -\nabla_k \cdot \nabla_x \log \left(M_n + e^{-\mu_n} \right) ,
$$

it also satisfies the solvability condition. Now (68) is written as

$$
\frac{M_n e^{-\mu_n}}{(M_n + e^{-\mu_n})^2} \nabla_k \varepsilon_n \cdot (\nabla_x V^0 - \nabla_x \mu_n) = L Q_n(f_n^0) f_n^1.
$$
\n(69)

Note that the factor in parentheses is independent of k. Thus, choosing a solution $h_n(k, \mu_n)$ of −µⁿ

$$
LQ_n(f_n^0)h_n = -\frac{M_n e^{-\mu_n}}{(M_n + e^{-\mu_n})^2} \nabla_k \varepsilon_n ,
$$
\n(70)

the solution of (69) can be written as

$$
f_n^1 = h_n(k, \mu_n) \cdot (\nabla_x V^0 - \nabla_x \mu_n) + \mu_n^1 f_n^0 (1 - f_n^0).
$$

Analogously

$$
f_p^1 = h_p(k, \mu_p) \cdot (\nabla_x V^0 + \nabla_x \mu_p) + \mu_p^1 f_p^0 (1 - f_p^0) \tag{71}
$$

is obtained (with $\mu_n^1(x,t)$ and $\mu_p^1(x,t)$ not specified, and not needed in the following). Finally, (42), (43) are divided by α^2 , integrated with respect to k and the limit $\alpha \to 0$ is carried out:

$$
\partial_t n + \nabla_x \cdot \int_B v_n f_n^1 \, dk = \int_B Q_{n,r}(f_n^0, f_{tr}^0) \, dk = \int_0^1 S_n(f_n^0, f_{tr}^0) \, dE \,,\tag{72}
$$

$$
\partial_t p + \nabla_x \cdot \int_B v_p f_p^1 \, dk = \int_B Q_{p,r}(f_p^0, f_{tr}^0) \, dk = \int_0^1 S_p(f_p^0, f_{tr}^0) \, dE \,. \tag{73}
$$

With the formulas for f_n^1 and f_p^1 , we obtain the drift-diffusion fluxes

$$
\int_B v_n f_n^1 dk = D_n(\mu_n) (\nabla_x V^0 - \nabla_x \mu_n) , \qquad \int_B v_p f_p^1 dk = D_p(\mu_p) (\nabla_x V^0 + \nabla_x \mu_p) ,
$$

with the diffusion matrices

$$
D_n = \int_B v_n \otimes h_n \, dk \,, \qquad D_p = \int_B v_p \otimes h_p \, dk \,.
$$

For the recombination-generation terms, we obtain

$$
S_n(f_n^0, f_{tr}^0) = \lambda_n \left[\frac{e^{-\mu_n}}{1 + e^{-\mu_n}/M_n} \right] (n_0 f_{tr}^0 - e^{\mu_n} (1 - f_{tr}^0)),
$$

\n
$$
S_p(f_p^0, f_{tr}^0) = \lambda_p \left[\frac{e^{\mu_p}}{1 + e^{\mu_p}/M_p} \right] (p_0 (1 - f_{tr}^0) - e^{-\mu_p} f_{tr}^0).
$$

Finally, we consider the small densities situation, when μ_n is large and negative and μ_p large and positive. This gives $n(\mu_n) \approx e^{\mu_n}$ and $p(\mu_p) \approx e^{-\mu_p}$. The above recombination-generation terms can then be approximated by the terms in (9) with $1/\tau_n = \lambda_n[M_n]$ and $1/\tau_p = \lambda_p[M_p]$.

The equation (70) for h_n can be approximated by

$$
\int_B \widetilde{\Phi}_n \big[M_n h'_n - M'_n h_n \big] \, dk' = -n M_n \nabla_k \varepsilon_n \,,
$$

implying $h_n = n\tilde{h}_n(k)$ and, thus, $D_n = n\tilde{D}_n$. With this and the analogous approximation for holes the macroscopic model becomes the drift-diffusion model from Section 2.

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